Vincotech

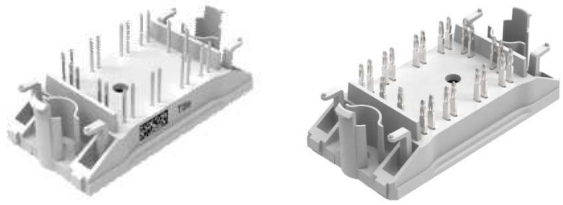
V23990-P629-L94-PM
V23990-P629-L94Y-PM
datasheet

flow BOOST 0 dual — 1200 V / 40 A

Features

- Ultra fast switching frequency
- Low Inductance Layout
- 1200V IGBT and 1200V SiC diode
- Antiparallel IGBT protection diode with high current
- Improved thermal Rth (AlN)

flow 0 17 mm housing

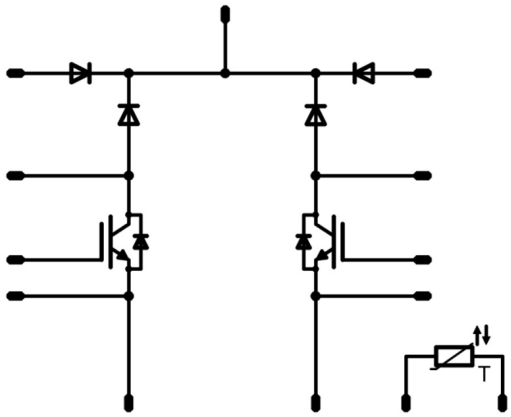


Solder Pin Press-fit

Target applications

- Solar inverter

Schematic



Types

- V23990-P629-L94-PM
- V23990-P629-L94Y-PM

Maximum Ratings

T_j=25°C, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit
Boost Switch					
Collector-emitter voltage	V_{CES}			1200	V
Collector current	I_C	$T_j = T_j$max	T_S=80 °C	55	A
Repetitive peak collector current	I_{CRM}	t_p limited by $T_j$max		160	A
Total power dissipation	P_{tot}	$T_j = T_j$max	T_S=80 °C	200	W
Gate-emitter voltage	V_{GES}			±25	V
Short circuit ratings	t_{SC} V_{CC}	$T_j \leq$ 125°C V_{GE} = 15V		10 600	µs V
Maximum Junction Temperature	T_{jmax}			150	°C

Parameter	Symbol	Conditions		Value	Unit
Boost Diode					
Peak Repetitive Reverse Voltage	V_{RRM}			1200	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$	T_h = 80°C	53	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_h = 80°C	161	W
Maximum Junction Temperature	T_{jmax}			175	°C

Parameter	Symbol	Conditions		Value	Unit
Boost Inverse Diode\Bypass Diode					
Peak Repetitive Reverse Voltage	V_{RRM}			1600	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$	T_h = 80°C	43	A
Surge (non-repetitive) forward current	I_{FSM}	50 Hz Single Half Sine Wave t_p = 10 ms 50 Hz sine	T_j = 150°C	200	A
Surge current capability	I^2t			200	A^2s
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_h = 80°C	63	W
Maximum Junction Temperature	T_{jmax}			150	°C

Parameter	Symbol	Conditions		Value	Unit
Module Properties					
Thermal Properties					
Storage temperature	T_{stg}			-40…+125	°C
Operation Junction Temperature	T_{jop}			-40…+(T_{jmax} - 25)	°C
Isolation Properties					
Isolation voltage	V_{isol}	DC voltage*	t_p = 2 s	6000	V
		AC Voltage	t_p = 1 min.	2500	V
Creepage distance				min 12,7	mm
Clearance				min 12,7	mm
Comparative Tracking Index	CTI			>200	

* 100 % tested in production

Characteristic Values

Boost Switch

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V]	V_{CE} [V]	I_C [A]	T_j[°C]	Min	Typ	Max	
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	V_{GE}=V_{CE}			0,00025	25 125	3,5	5,5	7,5	V
Collector-emitter saturation voltage	V_{CEsat}		15		40	25 125 150		2,74 3,01 -	3,2	V
Collector-emitter cut-off current	I_{CES}		0	1200		25 125			1000	µA
Gate-emitter leakage current	I_{GES}		25	0		25 125			300	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f=1 MHz	0	30		25		3200		pF
Output capacitance	C_{oes}							370		
Reverse transfer capacitance	C_{res}							125		
Gate charge	Q_g		15	600	40	25		220	330	nC
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal foil thickness=76um Kunze foil KU-ALF5						0,35		K/W
IGBT Switching										
Turn-on delay time	$t_{d(on)}$	R_{goff} = 4 Ω R_{gon} = 4 Ω	15/0	700	40	25 125		23 22		ns
Rise time	t_r					25 125		9 10		
Turn-off delay time	$t_{d(off)}$					25 125		165 197		
Fall time	t_f					25 125		16 49		
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 0,2 µC Q_{rFWD} = 0,2 µC				25 125		0,468 0,570		mWs
Turn-off energy (per pulse)	E_{off}					25 125		1,114 2,130		

Boost Diode

Parameter	Symbol	Conditions					Value			Unit
				V_r [V]	I_F [A]	T_j [°C]	Min	Typ	Max	
Static										
Forward voltage	V_F				30	25 125 150		1,43 1,76 1,89	1,6	V
Reverse leakage current	I_r			1200		25 150		 240	480	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal foil thickness = 76 µm Kunze foil KU-ALF5						0,59		K/W
FWD Switching										
Peak recovery current	I_{RRM}	di/dt = 4133 A/µs di/dt = 4920 A/µs	15/0	700	40	25 125		31 27		A
Reverse recovery time	t_{rr}					25 125		11 12		ns
Recovered charge	Q_r					25 125		0,164 0,162		µC
Reverse recovered energy	E_{rec}					25 125		0,019 0,020		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125		9136 6232		A/µs

Boost Inverse Diode\Bypass Diode

Parameter	Symbol	Conditions					Value			Unit
				V_r [V]	I_F [A]	T_j [°C]	Min	Typ	Max	
Static										
Forward voltage	V_F				25	25 125		1,22 1,21	1,90	V
Reverse leakage current	I_r			1600		25 145			50 1100	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal foil thickness = 76 µm Kunze foil KU-ALF5						1,11		K/W

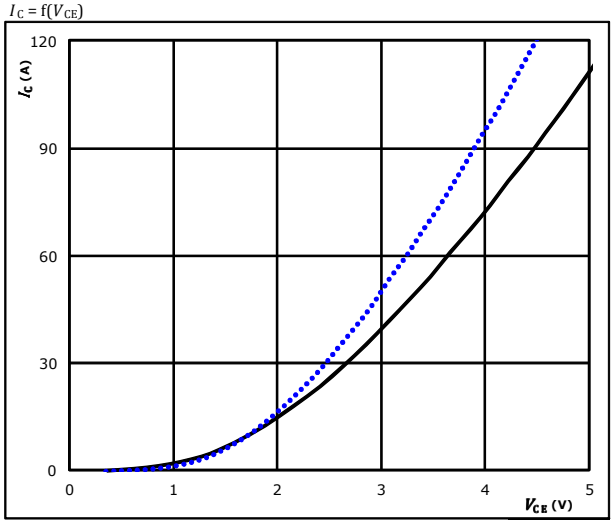
Thermistor

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V]	V_{CE} [V]	I_C [A]	T_j [°C]	Min	Typ	Max	
Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$\Delta_{R/R}$	R_{100} = 1484 Ω				100	-5		5	%
Power dissipation	P					25		5		mW
Power dissipation constant						25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±1 %				25		3962		K
B-value	$B_{(25/100)}$	Tol. ±1 %				25		4000		K
Vincotech NTC Reference									I	

Boost Switch Characteristics

Typical output characteristics **IGBT**

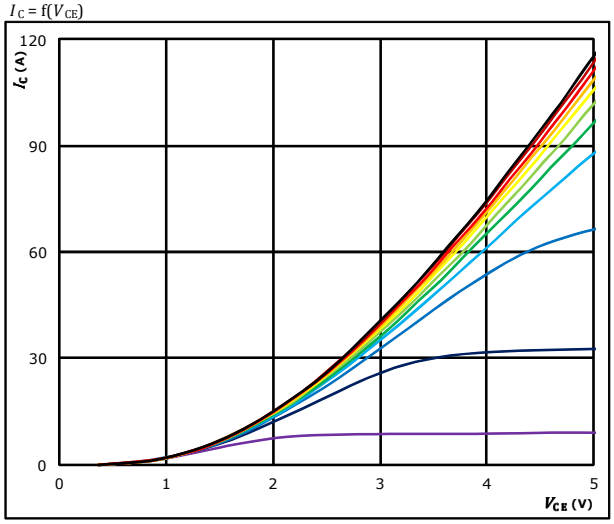
$I_C = f(V_{CE})$



t_p =	250	µs	25 °C
V_{GE} =	15	V	125 °C
			150 °C

Typical output characteristics **IGBT**

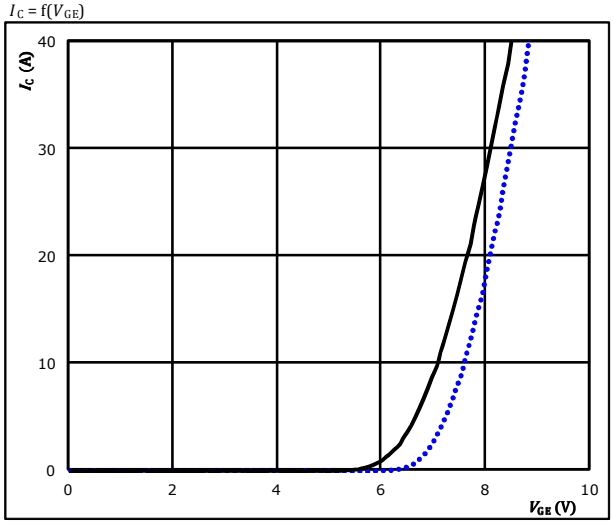
$I_C = f(V_{CE})$



t_p =	250	µs
T_j =	125	°C
V_{GE} from	7 V to 17 V in steps of 1 V	

Typical transfer characteristics **IGBT**

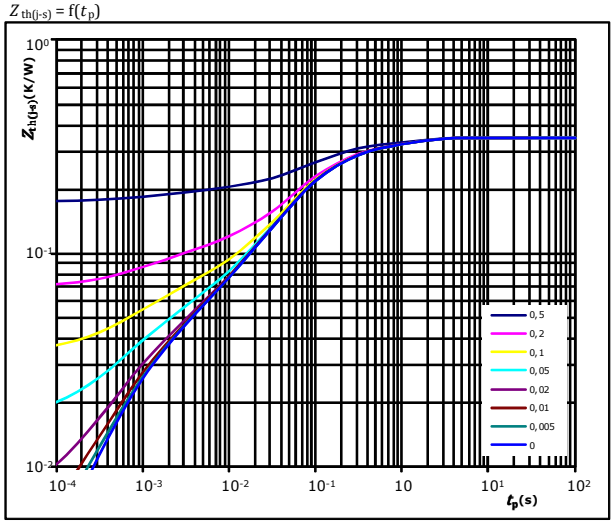
$I_C = f(V_{GE})$



t_p =	100	µs	25 °C
V_{CE} =	10	V	125 °C
			150 °C

Transient Thermal Impedance as function of Pulse duration **IGBT**

$Z_{th(j-s)} = f(t_p)$



D =	t_p / T	
$R_{th(j-s)}$ =	0,35	K/W

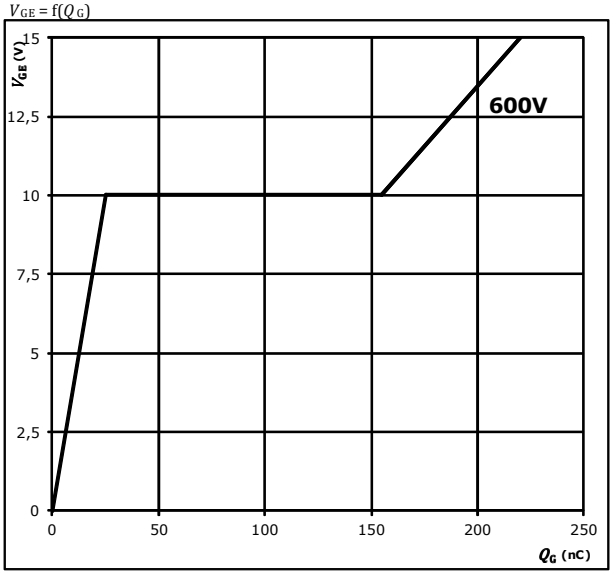
IGBT thermal model values

R_{th} (K/W)	τ (s)
7,21E-02	8,77E-01
1,40E-01	1,20E-01
1,02E-01	4,04E-02
2,88E-02	2,88E-03
1,74E-02	5,58E-04

Boost Switch Characteristics

Gate voltage vs Gate charge **IGBT**

$V_{GE} = f(Q_G)$



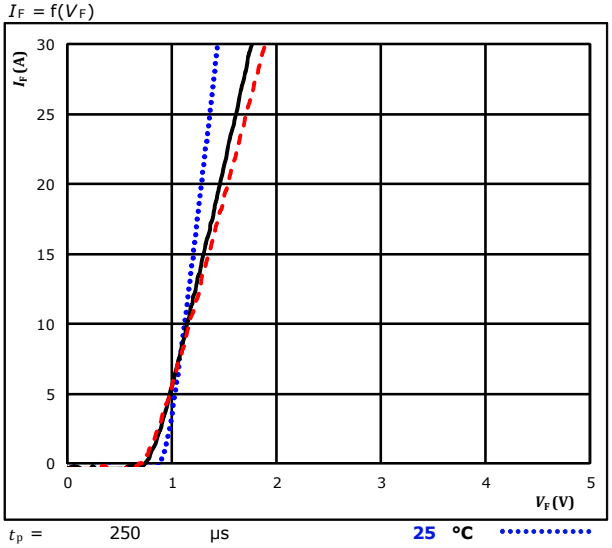
At

I_C= 40 A

Boost Inverse Diode\Bypass Diode Characteristics

Typical forward characteristics **FWD**

$I_F = f(V_F)$

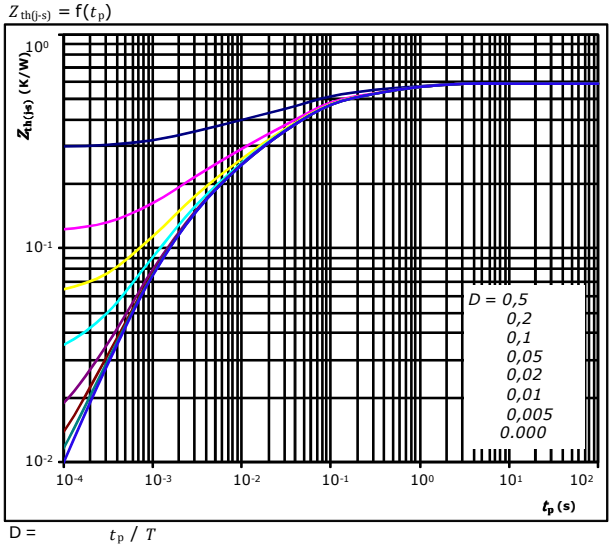


t_p = 250 µs

T_j: **25 °C**, **125 °C**, **150 °C**

Transient thermal impedance as a function of pulse width **FWD**

$Z_{th(j-s)} = f(t_p)$



D = t_p / T

$R_{th(j-s)}$ = 0,59 K/W

FWD thermal model values

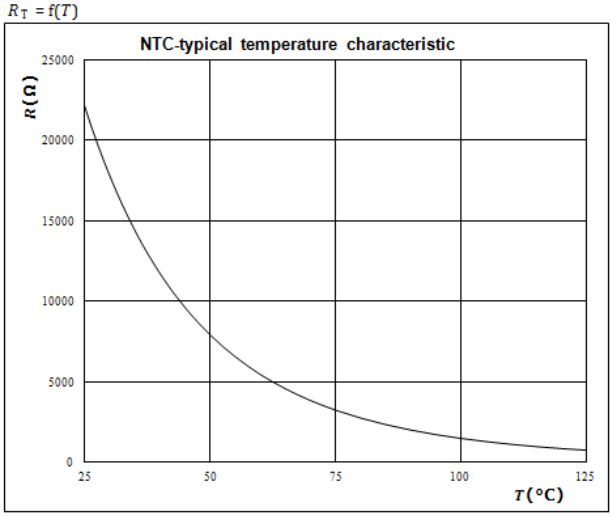
R (K/W)	τ (s)
9,95E-02	6,21E-01
2,05E-01	5,72E-02
1,13E-01	1,89E-02
1,14E-01	3,85E-03
5,90E-02	9,59E-04

Thermistor Characteristics

Thermistor typical temperature characteristic

Typical NTC characteristic
as a function of temperature

$R_T = f(T)$

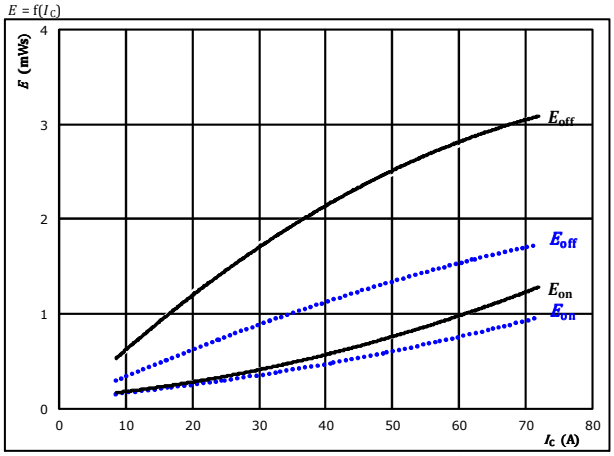


Boost Switching Characteristics

Figure 1. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



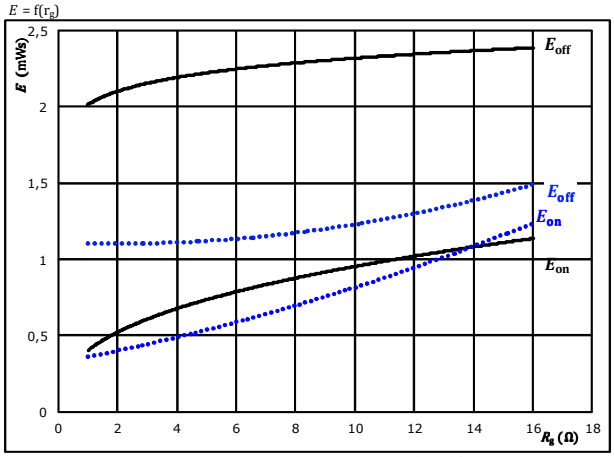
With an inductive load at

V_{CE} =	700	V	T_j:	25 °C
V_{GE} =	15/0	V		125 °C
R_{gon} =	4	Ω		150 °C
R_{goff} =	4	Ω		

Figure 2. **IGBT**

Typical switching energy losses as a function of gate resistor

$E = f(r_g)$



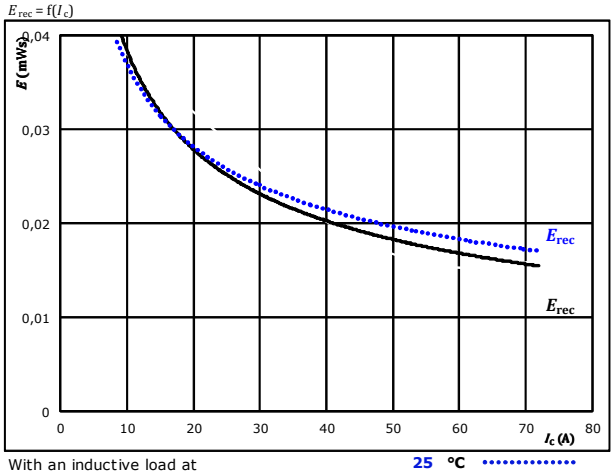
With an inductive load at

V_{CE} =	700	V	T_j:	25 °C
V_{GE} =	15/0	V		125 °C
I_C =	40	A		150 °C

Figure 3. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



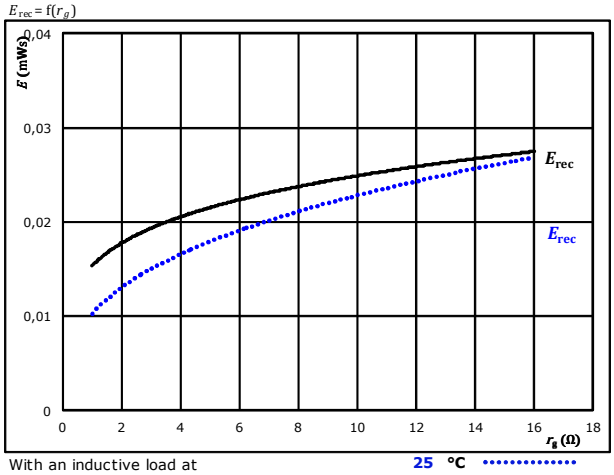
With an inductive load at

V_{CE} =	700	V	T_j:	25 °C
V_{GE} =	15/0	V		125 °C
R_{gon} =	4	Ω		150 °C

Figure 4. **FWD**

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(r_g)$



With an inductive load at

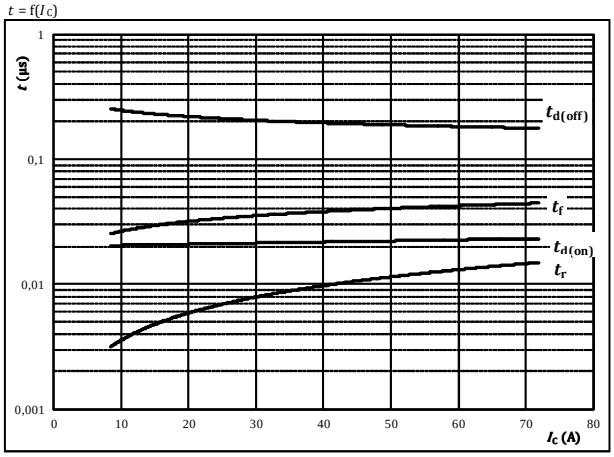
V_{CE} =	700	V	T_j:	25 °C
V_{GE} =	15/0	V		125 °C
I_C =	40	A		150 °C

Boost Switching Characteristics

Figure 5. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



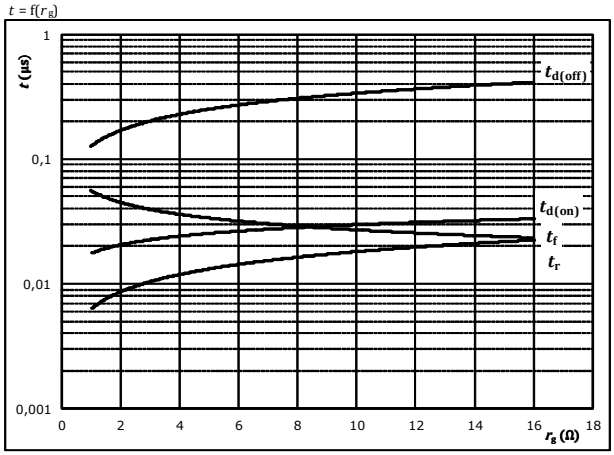
With an inductive load at

T_j =	125	°C
V_{CE} =	700	V
V_{GE} =	15/0	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

Figure 6. **IGBT**

Typical switching times as a function of gate resistor

$t = f(r_g)$



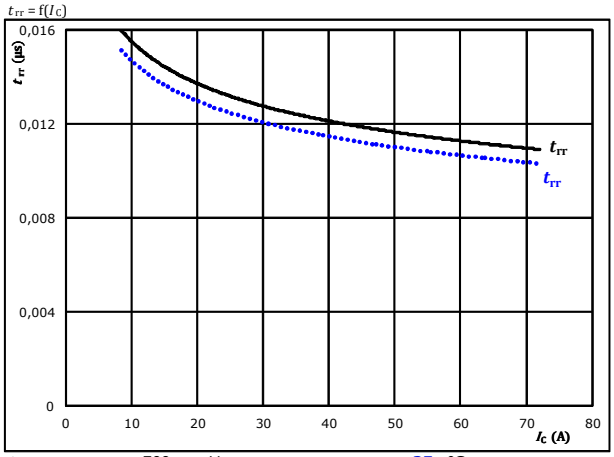
With an inductive load at

T_j =	125	°C
V_{CE} =	700	V
V_{GE} =	15/0	V
I_C =	40	A

Figure 7. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$

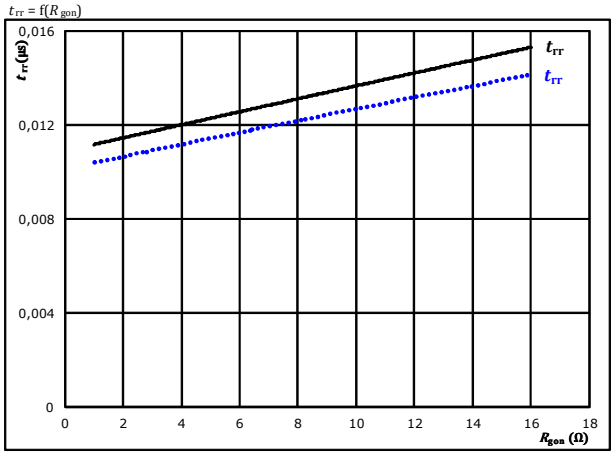


At					
V_{CE} =	700	V		25 °C	•••••••••••••••
V_{GE} =	15/0	V	T_j:	125 °C	———
R_{gon} =	4	Ω		150 °C	– – – –

Figure 8. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



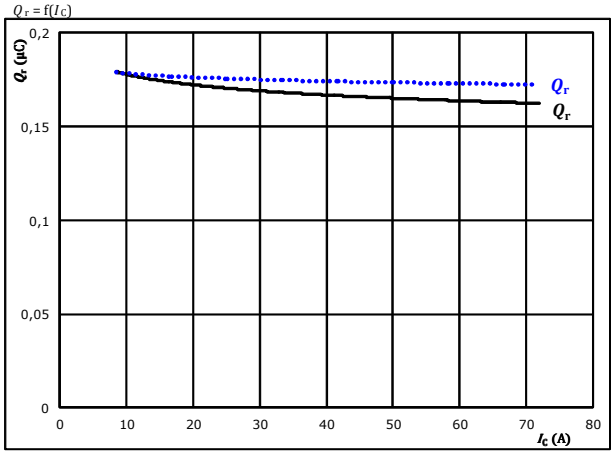
At					
V_{CE} =	700	V		25 °C	•••••••••••••••
V_{GE} =	15/0	V	T_j:	125 °C	———
I_C =	40	A		150 °C	– – – –

Boost Switching Characteristics

Figure 9. FWD

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$

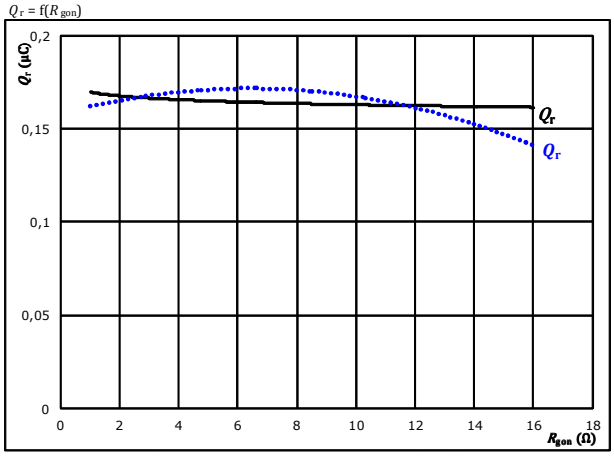


At					
	V_{CE} =	700	V		25 °C
	V_{GE} =	15/0	V	T_j:	125 °C
	R_{gon} =	4	Ω		150 °C

Figure 10. FWD

Typical recoved charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$

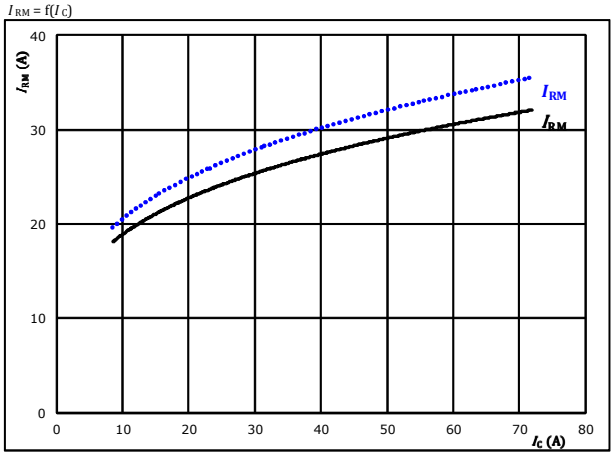


At					
	V_{CE}=	700	V		25 °C
	V_{GE} =	15/0	V	T_j:	125 °C
	I_C=	40	A		150 °C

Figure 11. FWD

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$

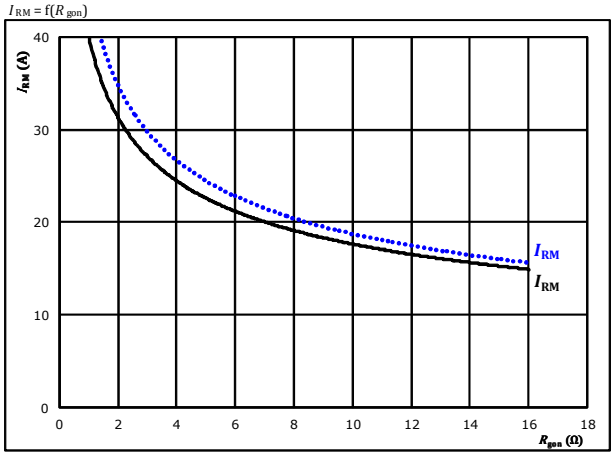


At					
	V_{CE} =	700	V		25 °C
	V_{GE} =	15/0	V	T_j:	125 °C
	R_{gon} =	4	Ω		150 °C

Figure 12. FWD

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



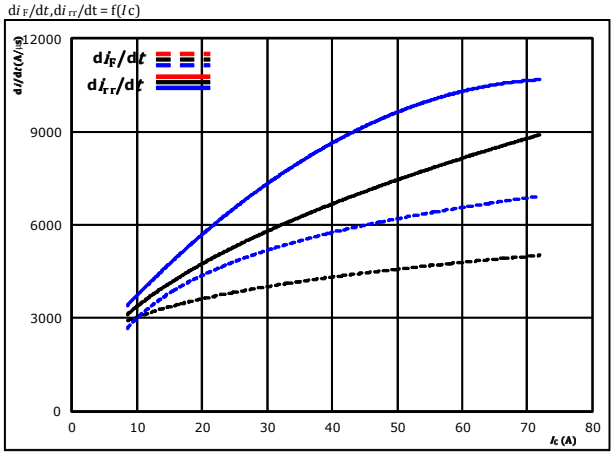
At					
	V_{CE} =	700	V		25 °C
	V_{GE} =	15/0	V	T_j:	125 °C
	I_C =	40	A		150 °C

Boost Switching Characteristics

Figure 13. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

$di_F/dt, di_{rr}/dt = f(I_C)$

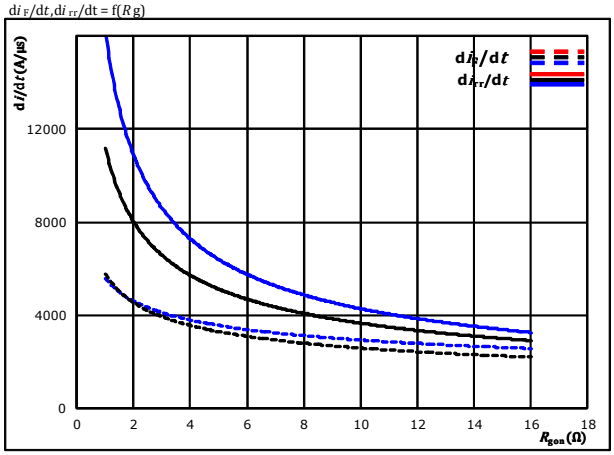


At					
V_{CE} =	700	V		25 °C	
V_{GE} =	15/0	V	T_j:	125 °C	
R_{gon} =	4	Ω		150 °C	

Figure 14. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$di_F/dt, di_{rr}/dt = f(R_g)$

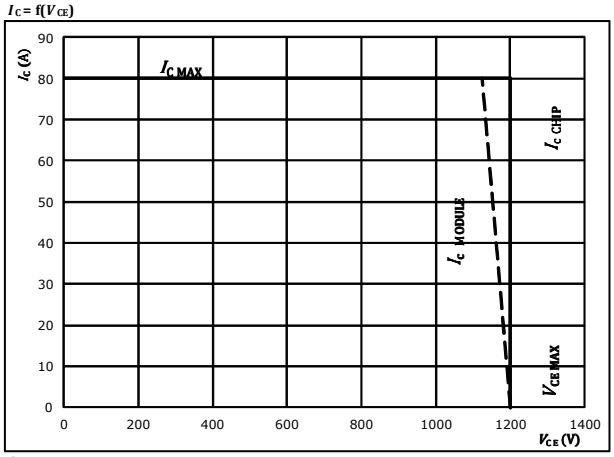


At			
V_{CE} =	700	V	
V_{GE} =	15/0	V	
I_C =	40	A	

Figure 15. **IGBT**

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

T_j =	175	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

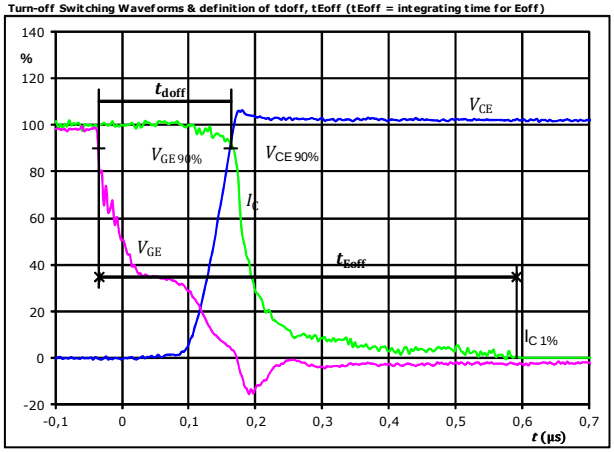
Boost Switching Definitions

General conditions

T_j	=	**125 °C**
R_{gon}	=	**4 Ω**
R_{goff}	=	**4 Ω**

Figure 1. IGBT

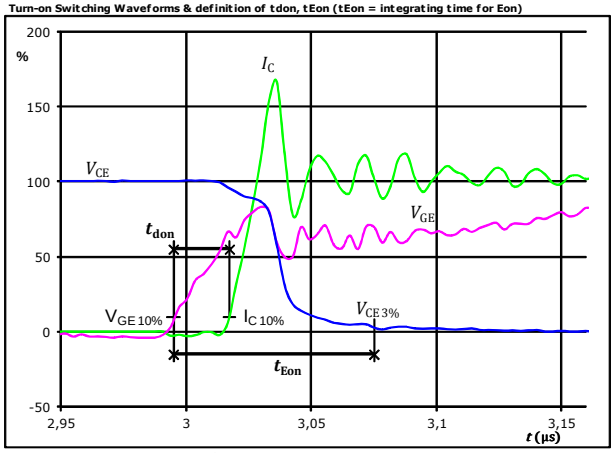
Turn-off Switching Waveforms & definition of tdoff, tEoff (tEoff = integrating time for Eoff)



$V_{GE}(0\%)$ =	0	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	700	V
$I_C(100\%)$ =	40	A
t_{doff} =	0,197	µs
t_{Eoff} =	0,626	µs

Figure 2. IGBT

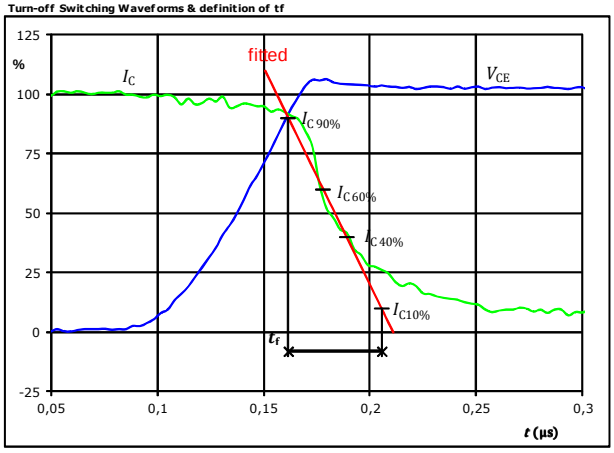
Turn-on Switching Waveforms & definition of tdon, tEon (tEon = integrating time for Eon)



$V_{GE}(0\%)$ =	0	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	700	V
$I_C(100\%)$ =	40	A
t_{don} =	0,022	µs
t_{Eon} =	0,080	µs

Figure 3. IGBT

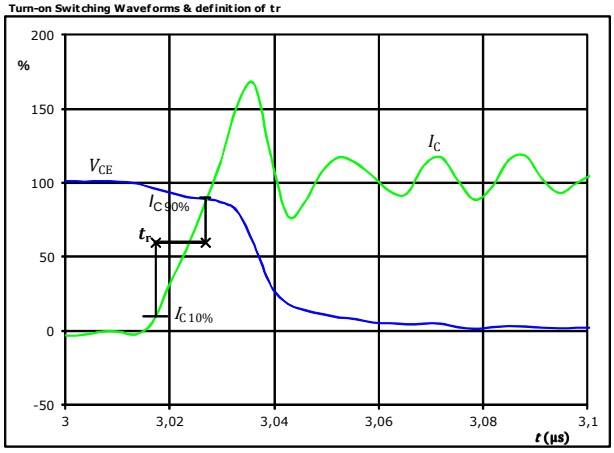
Turn-off Switching Waveforms & definition of tf



$V_C(100\%)$ =	700	V
$I_C(100\%)$ =	40	A
t_f =	0,049	µs

Figure 4. IGBT

Turn-on Switching Waveforms & definition of tr

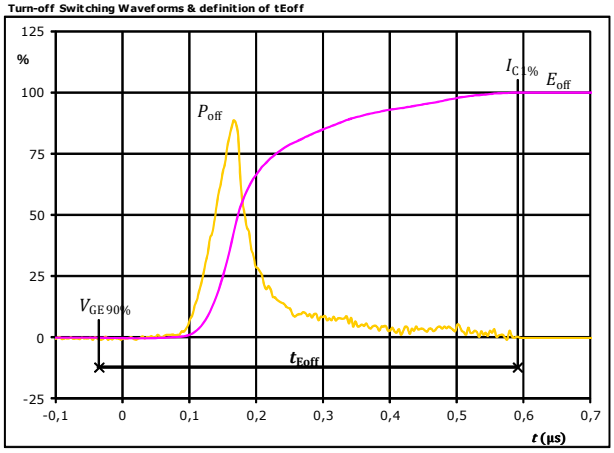


$V_C(100\%)$ =	700	V
$I_C(100\%)$ =	40	A
t_r =	0,010	µs

Boost Switching Definitions

Figure 5. **IGBT**

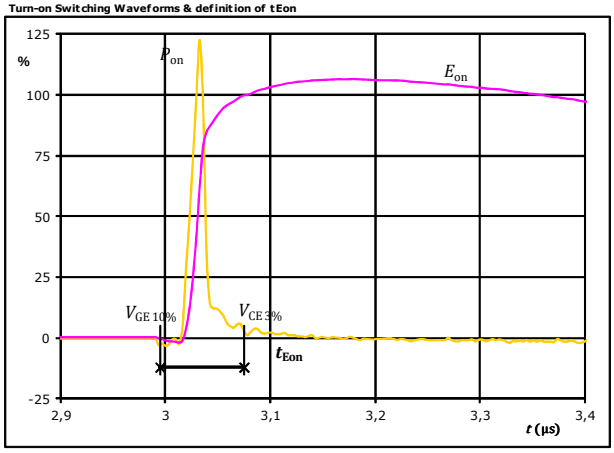
Turn-off Switching Waveforms & definition of tEoff



$P_{off}(100\%)$ =	27,89	kW
$E_{off}(100\%)$ =	2,13	mJ
t_{Eoff} =	0,63	µs

Figure 6. **IGBT**

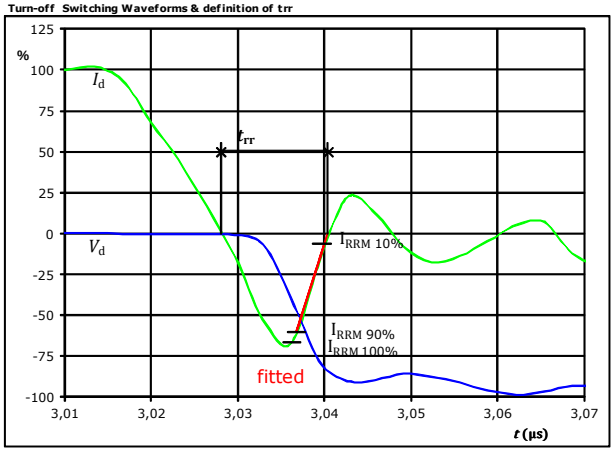
Turn-on Switching Waveforms & definition of tEon



$P_{on}(100\%)$ =	27,89	kW
$E_{on}(100\%)$ =	0,57	mJ
t_{Eon} =	0,08	µs

Figure 7. **FWD**

Turn-off Switching Waveforms & definition of trr

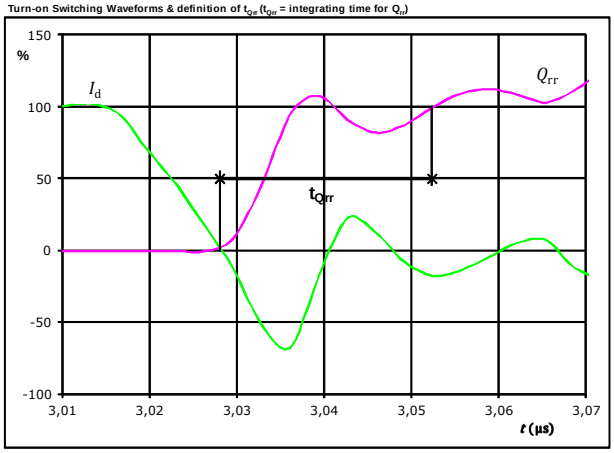


$V_d(100\%)$ =	700	V
$I_d(100\%)$ =	40	A
$I_{RRM}(100\%)$ =	-27	A
t_{rr} =	0,012	µs

Boost Switching Definitions

Figure 8. **FWD**

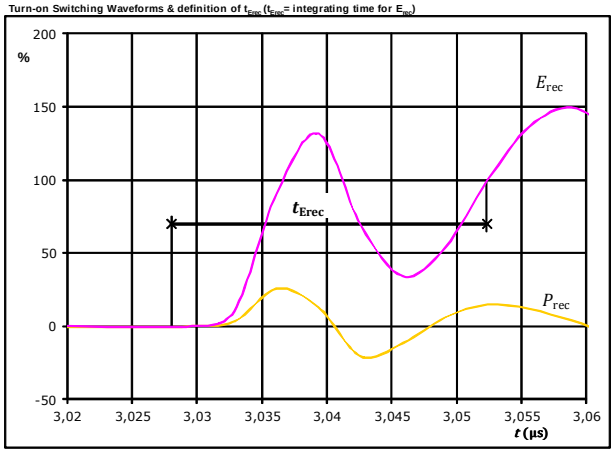
Turn-on Switching Waveforms & definition of t_{Qrr} (t_{Qrr} = integrating time for Q_{rr})



$I_d(100\%)$ =	40	A
$Q_{rr}(100\%)$ =	0,16	µC
t_{Qrr} =	0,02	µs

Figure 9. **FWD**

Turn-on Switching Waveforms & definition of t_{Erec} (t_{Erec}= integrating time for E_{rec})



$P_{rec}(100\%)$ =	27,89	kW
$E_{rec}(100\%)$ =	0,02	mJ
t_{Erec} =	0,02	µs

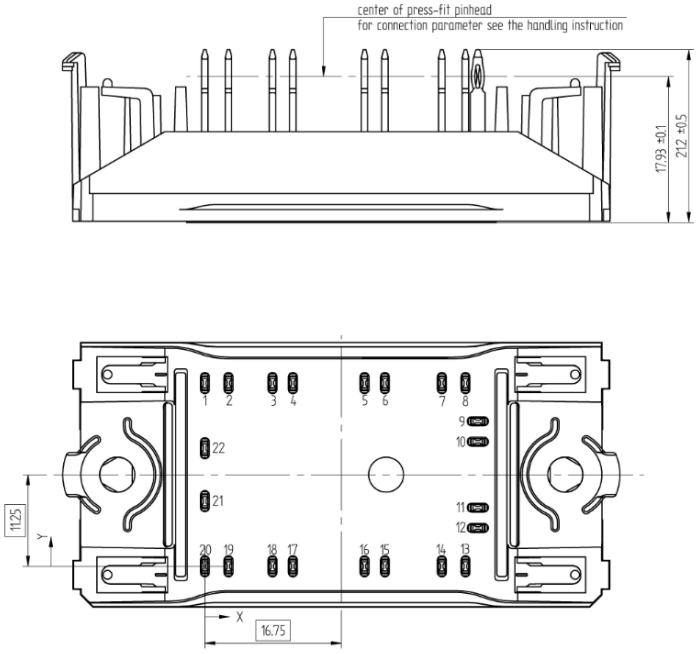
Ordering Code & Marking

Version	Ordering Code
w\o thermal paste 17mm housing with solder pins	V23990-P629-L94-PM
w\o thermal paste 17mm housing with Press-fit pins	V23990-P629-L94Y-PM

		Name		Date code	UL & VIN	Lot	Serial
Text		NN-NNNNNNNNNNNNN-NNNNNNNN		WWYY	UL VIN	LLLLL	SSSS
		Type&Ver	**Lot number**	**Serial**	**Date code**		
Datamatrix		TTTTTTTVV	LLLLL	SSSS	WWYY		

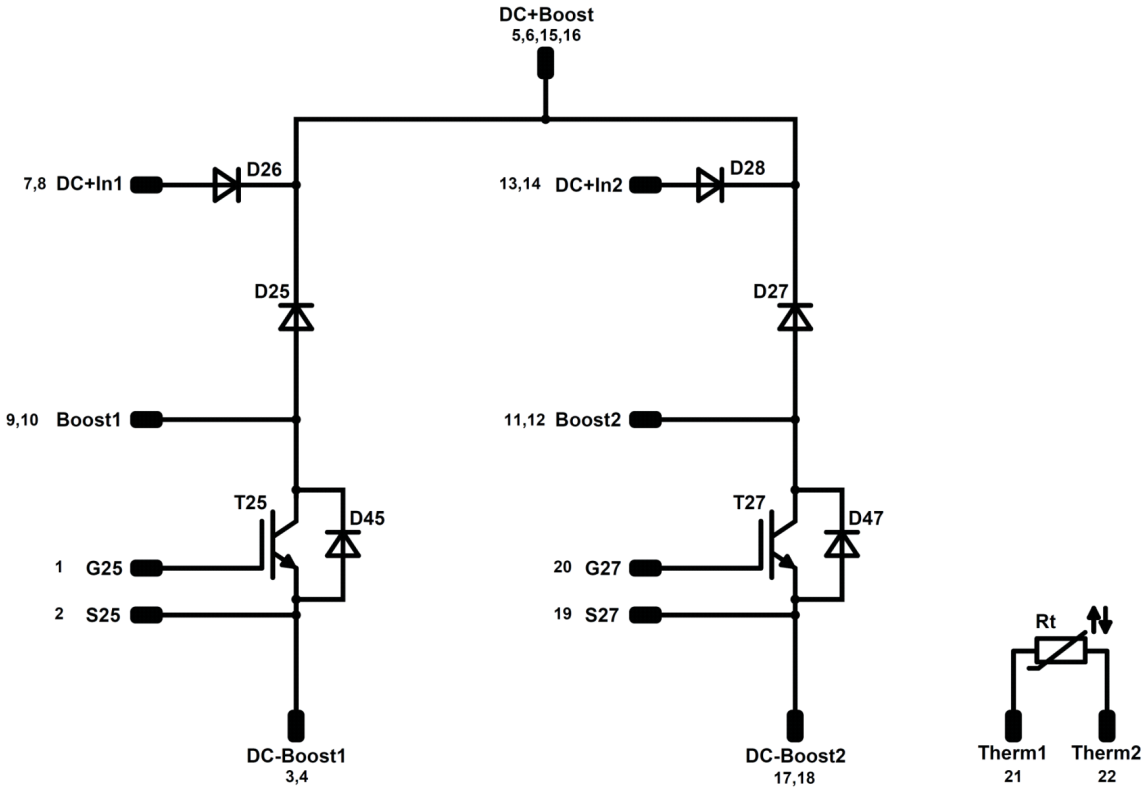
Outline

Pin table [mm]			
Pin	X	Y	Function
1	0	22,5	G25
2	2,9	22,5	S25
3	8,3	22,5	DC-Boost1
4	10,8	22,5	DC-Boost1
5	19,6	22,5	DC+Boost
6	22,1	22,5	DC+Boost
7	29,1	22,5	DC+In1
8	32	22,5	DC+In1
9	33,5	17,8	Boost1
10	33,5	15,3	Boost1
11	33,5	7,2	Boost2
12	33,5	4,7	Boost2
13	32	0	DC+In2
14	29,1	0	DC+In2
15	22,1	0	DC+Boost
16	19,6	0	DC+Boost
17	10,8	0	DC-Boost2
18	8,3	0	DC-Boost2
19	2,9	0	S27
20	0	0	G27
21	0	8	Therm1
22	0	14,5	Therm2



Tolerance of pinpositions: ±0.5mm at the end of pins
Dimension of coordinate axis is only offset without tolerance

Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T25,T27	IGBT	1200V	40A	Boost Switch	FGL40N120ANDT
D25,D27	FWD	1200V	30A	Boost Diode	S6302TCS
D45,D47	Rectifier	1600V	25A	Boost Inverse Diode	SKR 3,5QU/16B
D26,D28	Rectifier	1600V	25A	Bypass Diode	SKR 3,5QU/16B
Rt	NTC			Thermistor	

Packaging instruction					
Standard packaging quantity (SPQ)	135	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for *flow* 0 packages see vincotech.com website.

Package data
Package data for *flow* 0 packages see vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website.

Document No.:	Date:	Modification:	Pages
V23990-P629-L94x-D4-14	01 Sep. 2017	Ir value updated	4

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